Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/699,879	YOON ET AL.
	Examiner	Art Unit
	Dennis Rosario	2824

SEARCHED			
Class	Subclass	Date	Examiner
382	224 (117)	2/12/07 2/17/07 2/8/07	DR DR DR
	117	↓	↓
	(118)	8/31/07	(DR)

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
See PG Pub interference search history printout		8/31/07	DR

SEARCH NOTES (INCLUDING SEARCH STRATEGY)	DATE	EXMR
(updated) (East, all dB)	2/12/07 (5/17/07) (8/31/07)	DR (DR) (DR)
IEEE - "principle component analysis" and occlu* —	2/9/07	DR
— eign* <near> weight* and (face or facial) —	2/8/07	DR
IEEE — eign* and face and (cover* or occlu*) —	5/17/07	DR
IEEE — face or facial and (-1 and or negative) and eigen* —	8/31/07	DR
PG Pub interference search history printout	8/31/07	DR
inventor	8/31/07	DR